

Notice of References Cited	Application/Control No. 10/617,901	Applicant(s)/Patent Under Reexamination DUNKLE, MARK VANDEVERT	
	Examiner Usmaan Saeed	Art Unit 2166	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,587,930 A	12-1996	Hori et al.	702/185
	B	US-5,777,876 A	07-1998	Beauchesne, Robert C.	700/95
	C	US-6,061,685 A	05-2000	Fantenberg, Johan	707/10
	D	US-6,070,188 A	05-2000	Grant et al.	709/223
	E	US-6,128,588 A	10-2000	Chacon, Guillermo Rudolfo	703/6
	F	US-2003/0046027 A1	03-2003	Kitamura et al.	702/182
	G	US-6,665,662 B1	12-2003	Kirkwood et al.	707/3
	H	US-2003/0236628 A1	12-2003	Martorana et al.	702/9
	I	US-6,820,076 B2	11-2004	Bailey et al.	707/3
	J	US-2005/0271132 A1	12-2005	Kolenc et al.	375/226
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.